



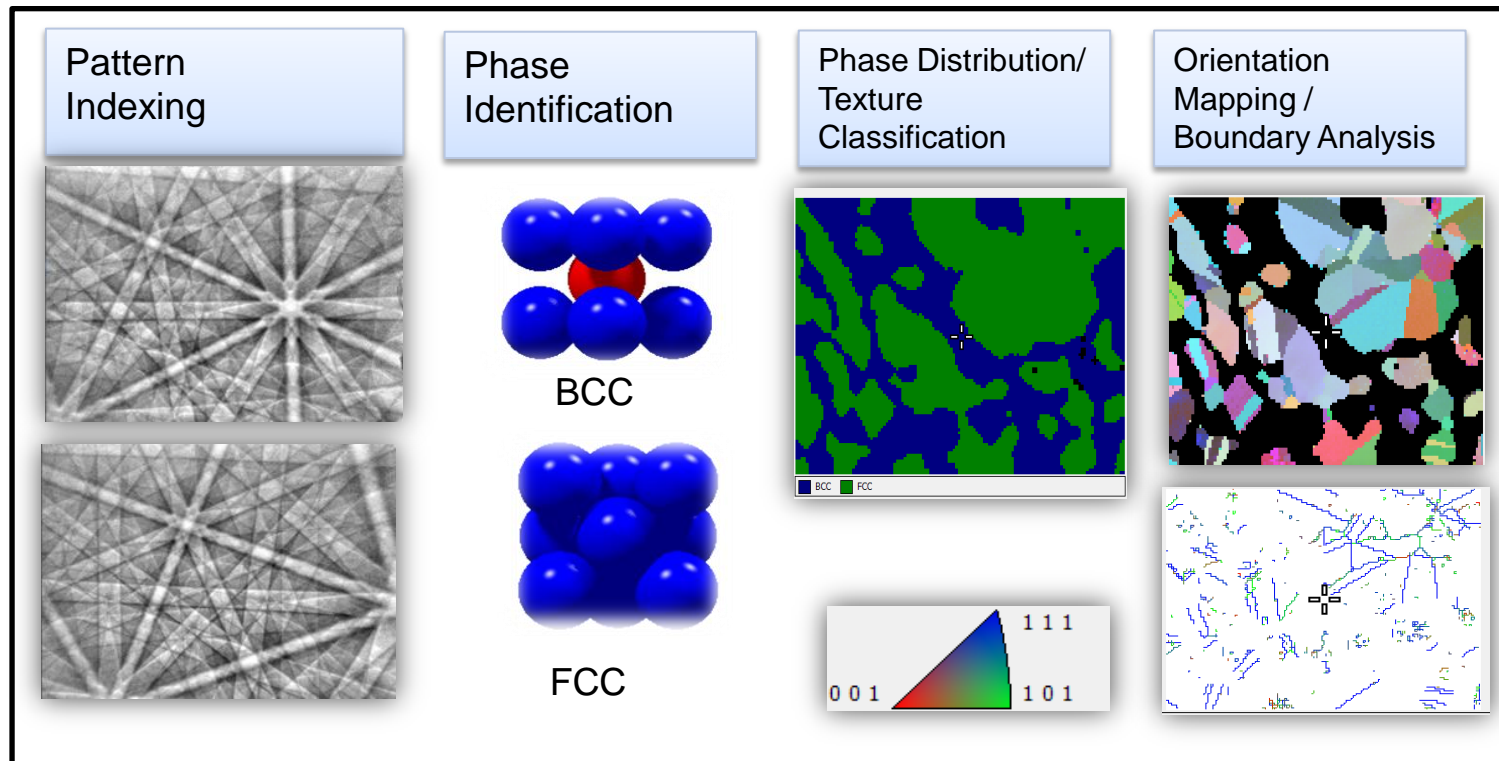
MAGCIS – A Novel Method for EBSD Surface Preparation

Webinar Outline

- Introduction
- Review of EBSD preparation techniques
- Introducing MAGCIS for EBSD
- Application Examples

EBSD Introduction

- EBSD is used in a wide number of disciplines
- Traditionally used in metallurgical applications, now many new areas
- Vast amount of information from a single dataset



EBSD Comparisons

EBSD offers many advantages over other structural characterisation techniques

vs TEM

- Analysis of bulk samples
- Statistically more reliable
- Simplified preparation routines

vs XRD

- Greater spatial resolution
- Relation between microstructure and texture

vs Optical Microscopy

- Improved resolution and higher magnification
- More comprehensive information, readily combined with other techniques

EBSD Operating Parameters

Microscope Parameters:

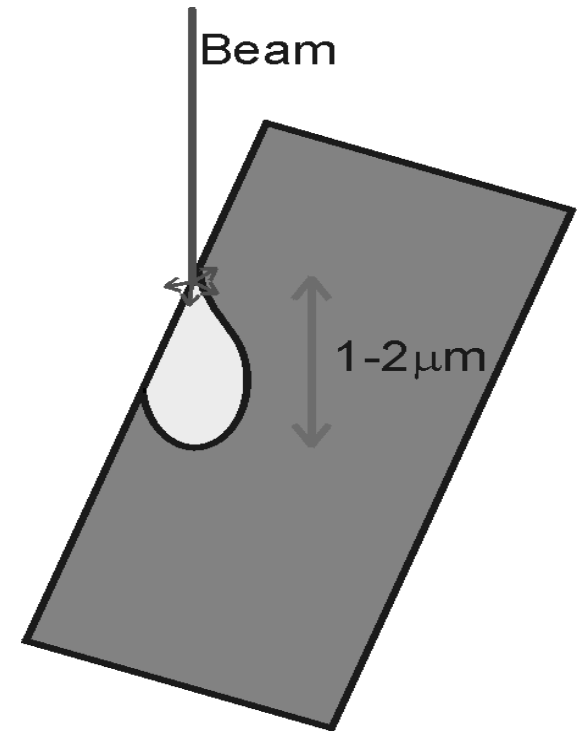
- Working Distance - <5 mm - >40 mm
- Probe current - <2 nA
- Accelerating voltage <5 kV - >30 kV

EBSD System Parameters:

- Spatial resolution - <20 nm
- Angular resolution - $<0.5^\circ$
- Indexing speed - >500 pts/sec
- Symmetry – Triclinic and above

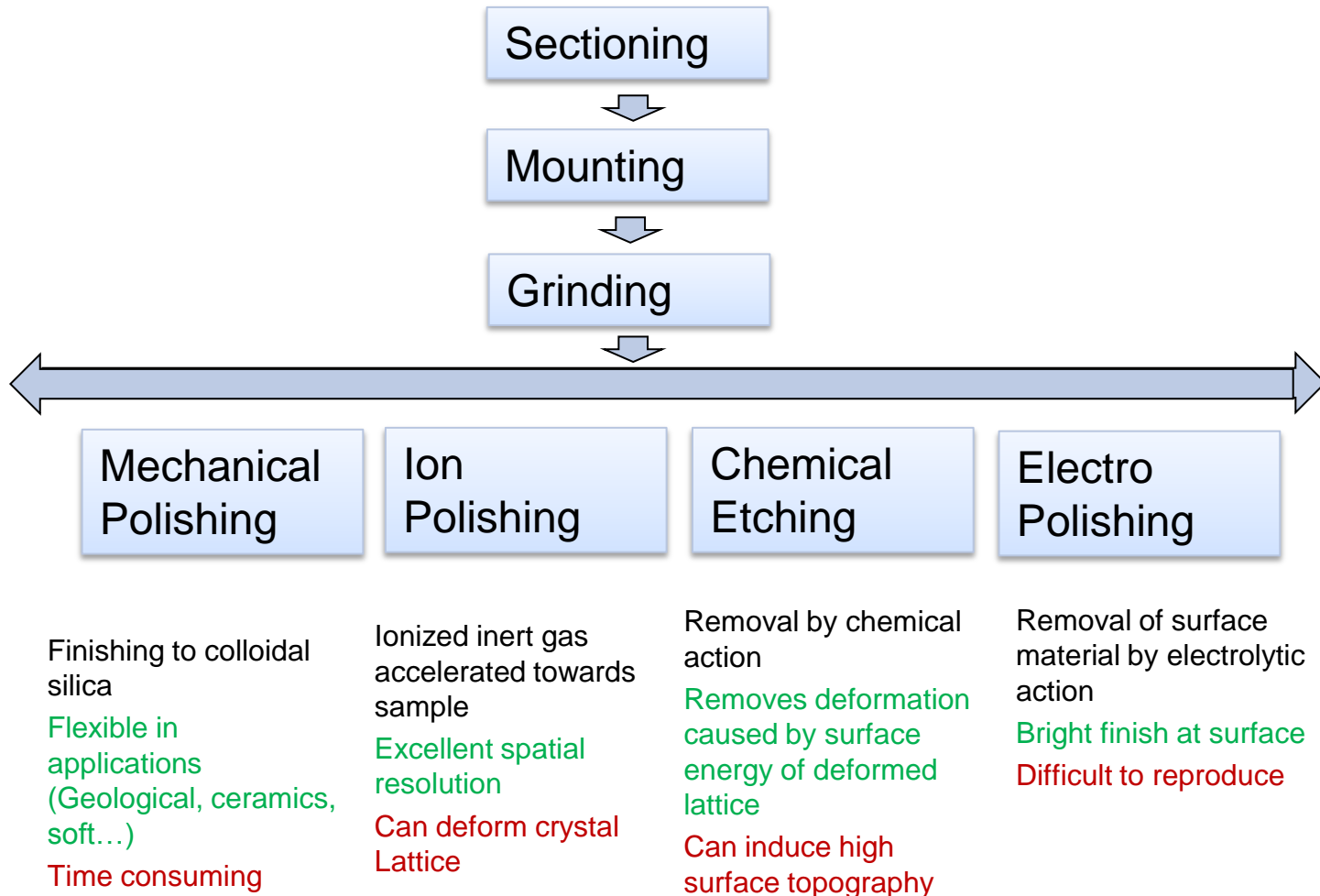
EBSD Sample Preparation

- Good surface preparation is essential
 - Diffraction pattern signal originates from the top few nm of the surface
 - Damage-free crystal lattice
 - Residual deformation
 - High tilt angle can result in shadowing
- Choose the most appropriate technique for your material
- Many preparation techniques actually impair EBSP pattern quality



Common EBSD Sample Preparation Techniques

- A range of sample preparation techniques are commonly used in EBSD



Introducing MAGCIS

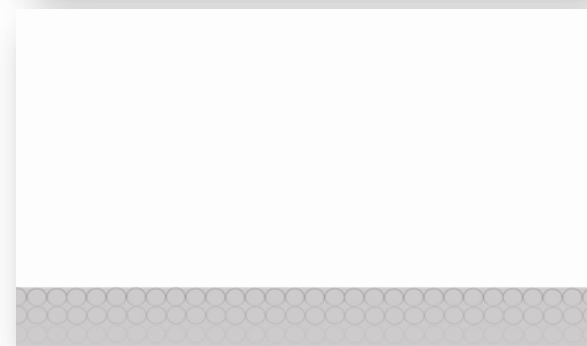
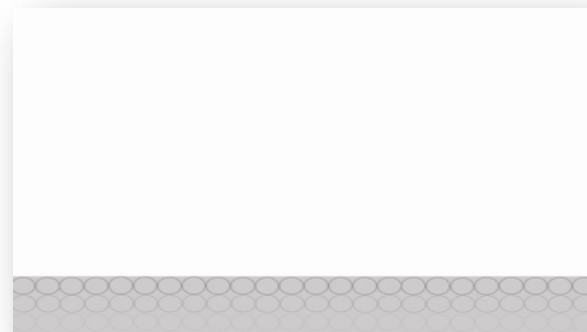
- Monatomic And Gas Cluster Ion Source (MAGCIS)
- Originally developed for XPS market
- Single source for monatomic and cluster beams

Monatomic mode

- Comparable to standard ion polishing
- 500eV-4keV with high beam currents

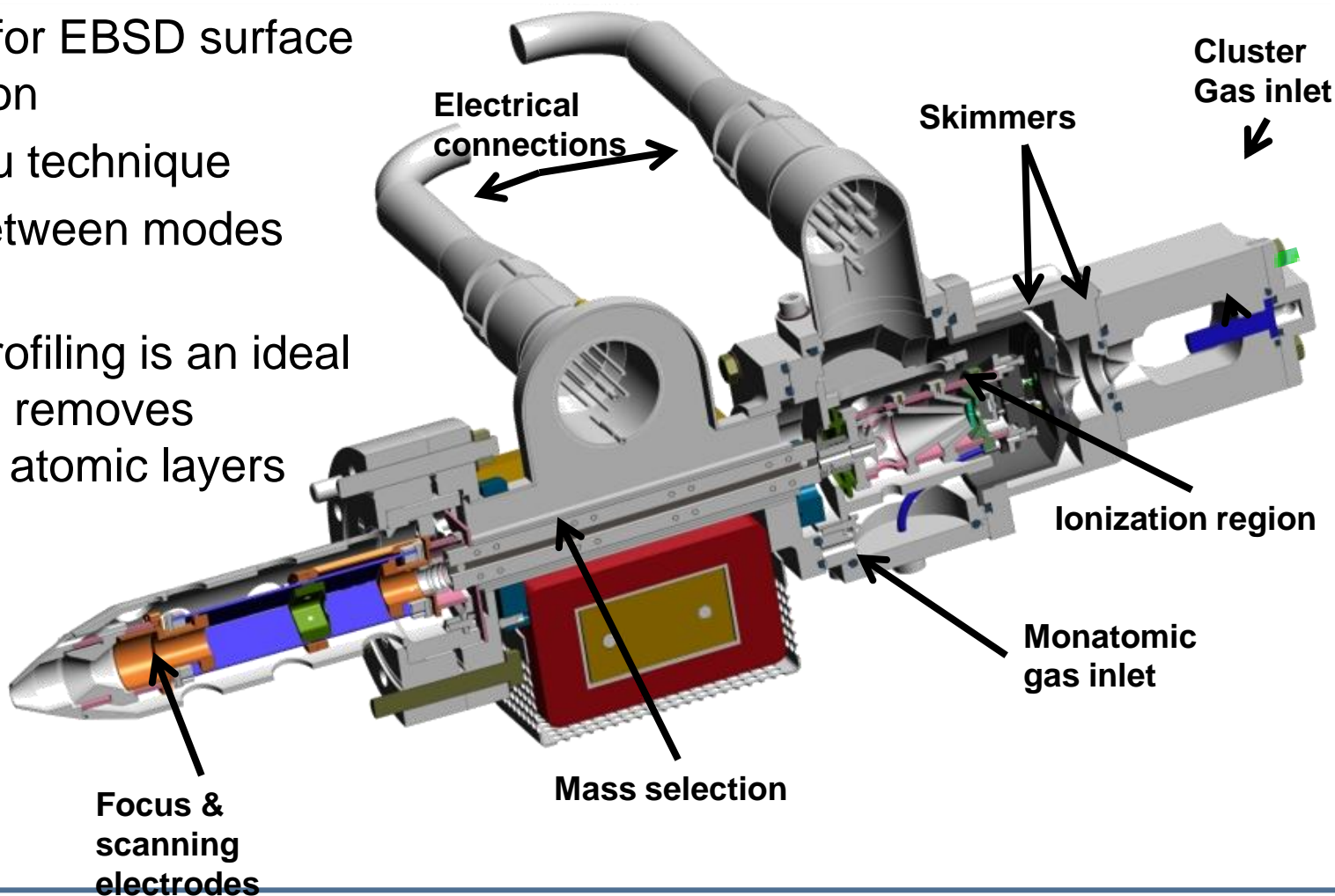
Cluster mode

- Variable cluster sizes ($0 < n < 2000$ atoms)
- Energy/atom: 1eV upwards
- Extra low beam energies possible (1000eV & 2000eV modes)

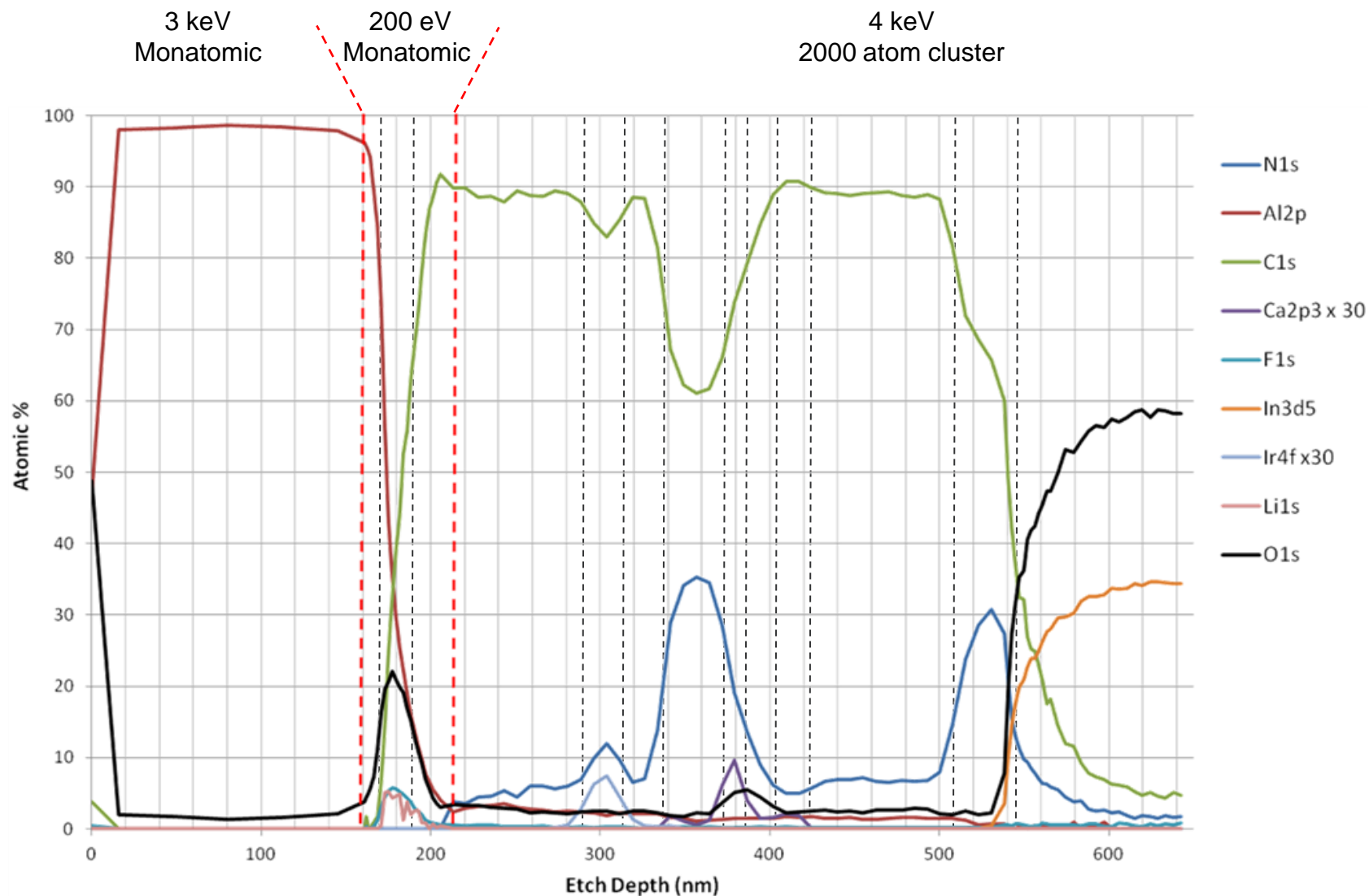


MAGCIS Advantages

- MAGCIS offers excellent potential for EBSD surface preparation
- Full in-situ technique
- Switch between modes instantly
- Cluster profiling is an ideal final step, removes individual atomic layers

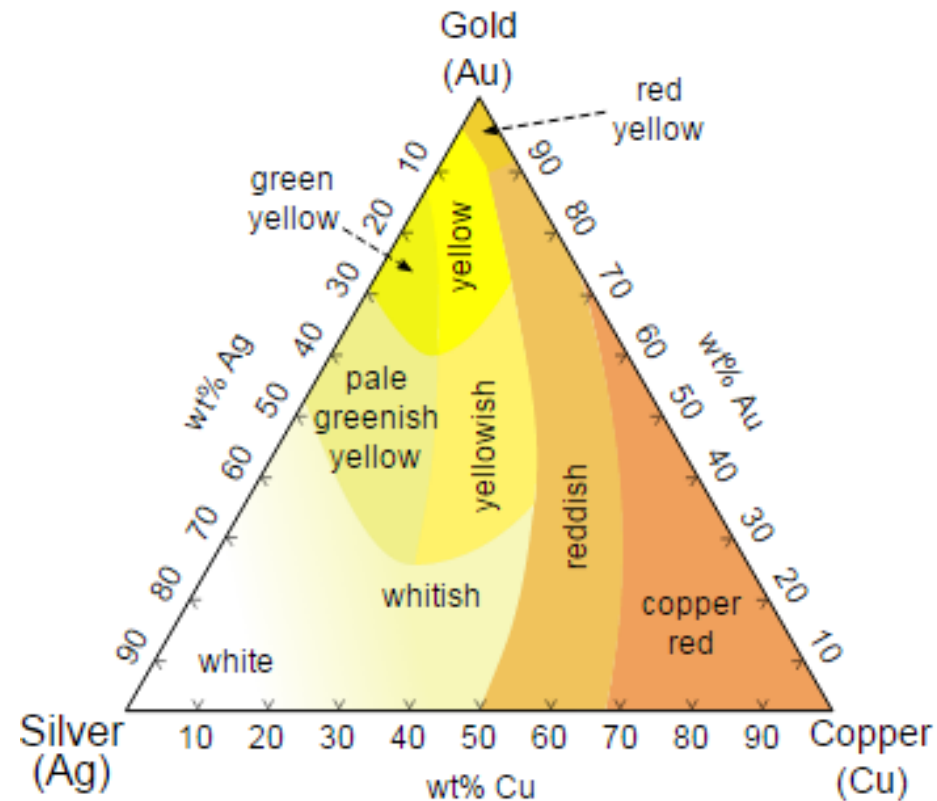


Elemental Profile



Application 1: Au Alloy

- 'Red Gold' is a gold and copper alloy widely used in industry.
- The microstructure of the material is related to the alloy composition and production conditions
- Gold alloys are usually soft making them difficult to prepare for EBSD analysis

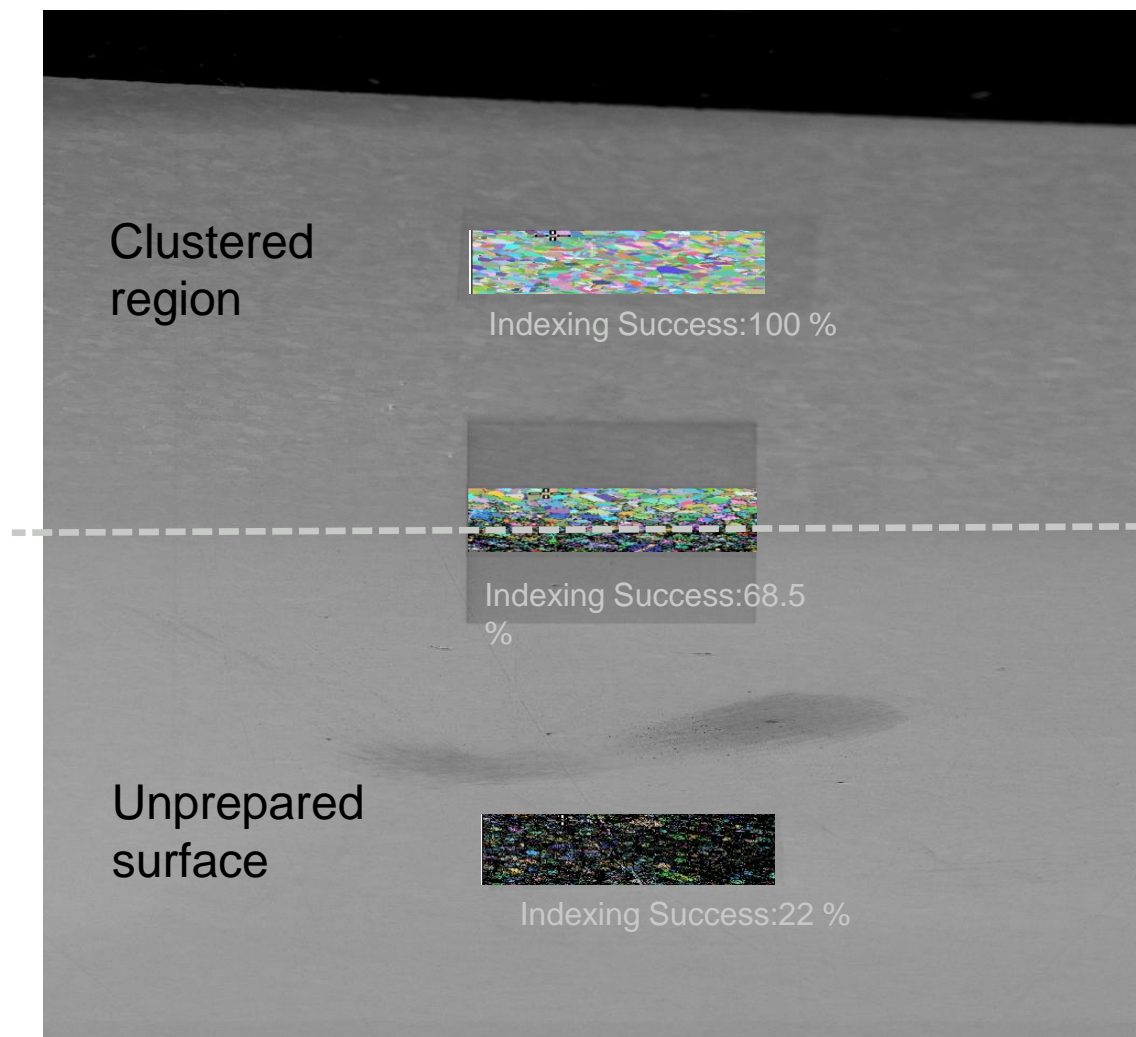


Application 1: Sample Preparation

- Sample: cold treated Au:Cu alloy – FCC structure –
- Polished using colloidal Si suspension
- Initially polished with, following a standard recipe for gold, this yielded a very low overall indexing quality <10%
- Prepared using cluster ion source on, 20 minutes at 3 kV Monoatomic, 2 minutes cluster profile as a final step
- Milling area 1 x 2 mm

Application 1: Sample Overview

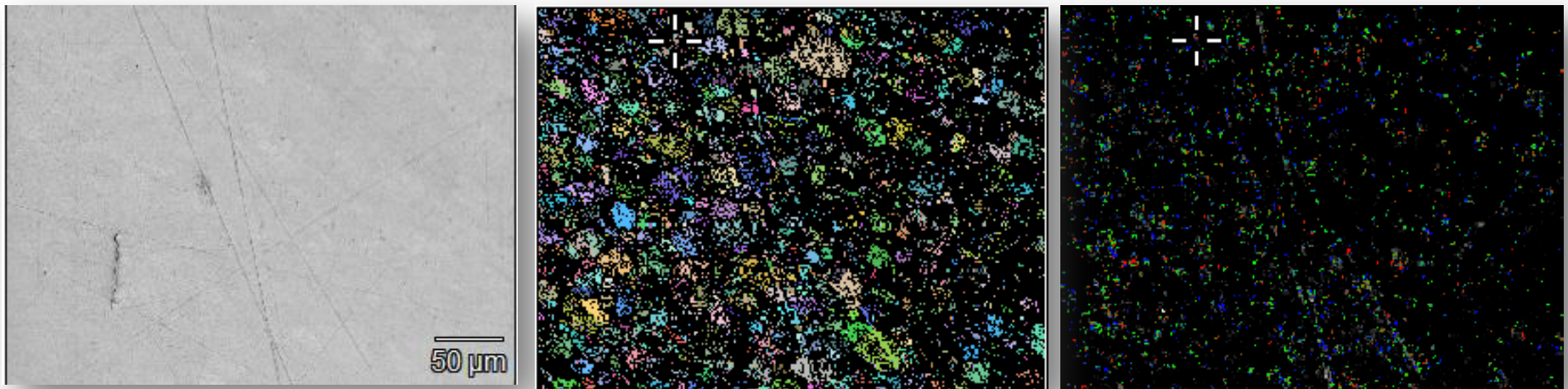
- Differences between milled and unmilled areas.
- 3 regions selected from sample, milled, unprepared and transition
- EBSD data acquired under same conditions for each region



Application 1: Unprepared Region

- Regions prepared using traditional polishing techniques have low quality Kikuchi patterns
- Deformation over several levels
- Longer exposure times required using this approach

Image Resolution:	1024 by 768
Image Pixel Size:	0.33 μm
Acc. Voltage:	20.0 kV
Magnification:	400
Exposure Time:	9.0 ms
Indexing Success:	22 %

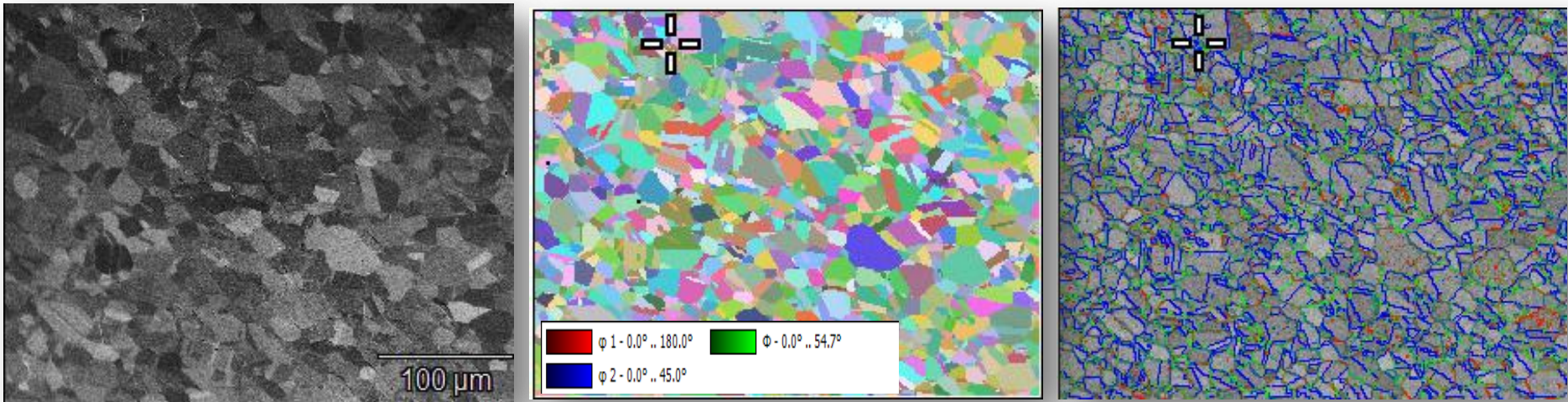


Left SEI image of mechanically polished surfaces. **Centre** Orientation image map showing a low overall indexing success **Right** Grain boundary map, which does not return any meaningful information

Application 1: MAGCIS Cluster Region

- Regions prepared using MAGCIS cluster polishing have high quality Kikuchi patterns
- Indexing success of 100% Enables rapid analysis of large areas

Image Resolution:	1024 by 768
Image Pixel Size:	0.38 μm
Acc. Voltage:	20.0 kV
Magnification:	400x
Exposure Time:	9.0 ms
Indexing Success:	100.0 %

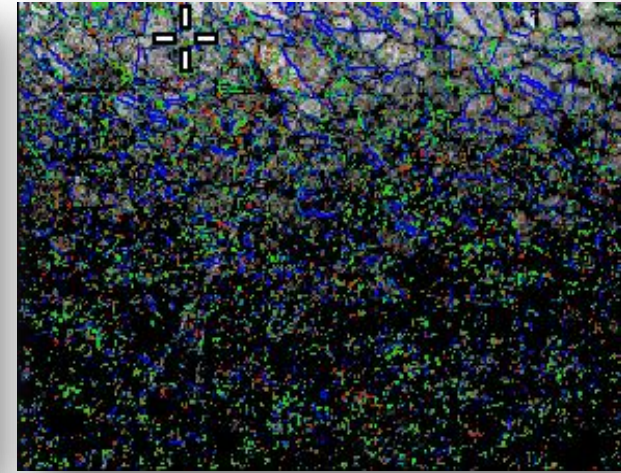
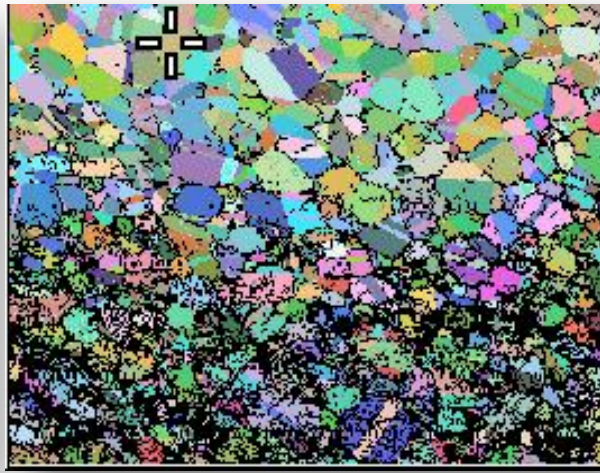
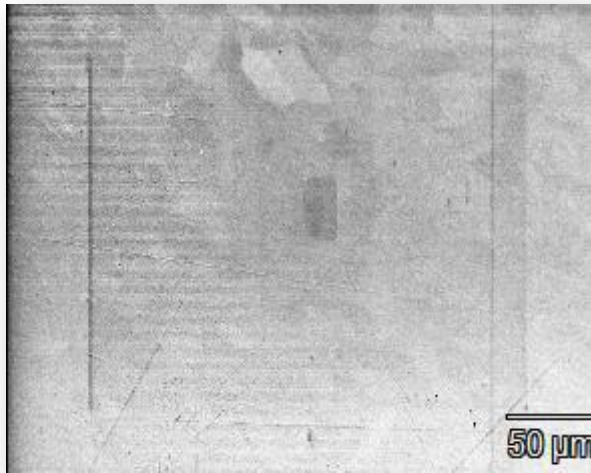


Left SEI image of MAGCIS polished surfaces. **Centre** Orientation image map showing a high overall indexing success **Right** Grain boundary angle map, showing a preferred microtexture

Application 1: Transition Region

- EBSD analysis of a transition region
- Partial indexing success close to interface
- Large grains successfully indexed

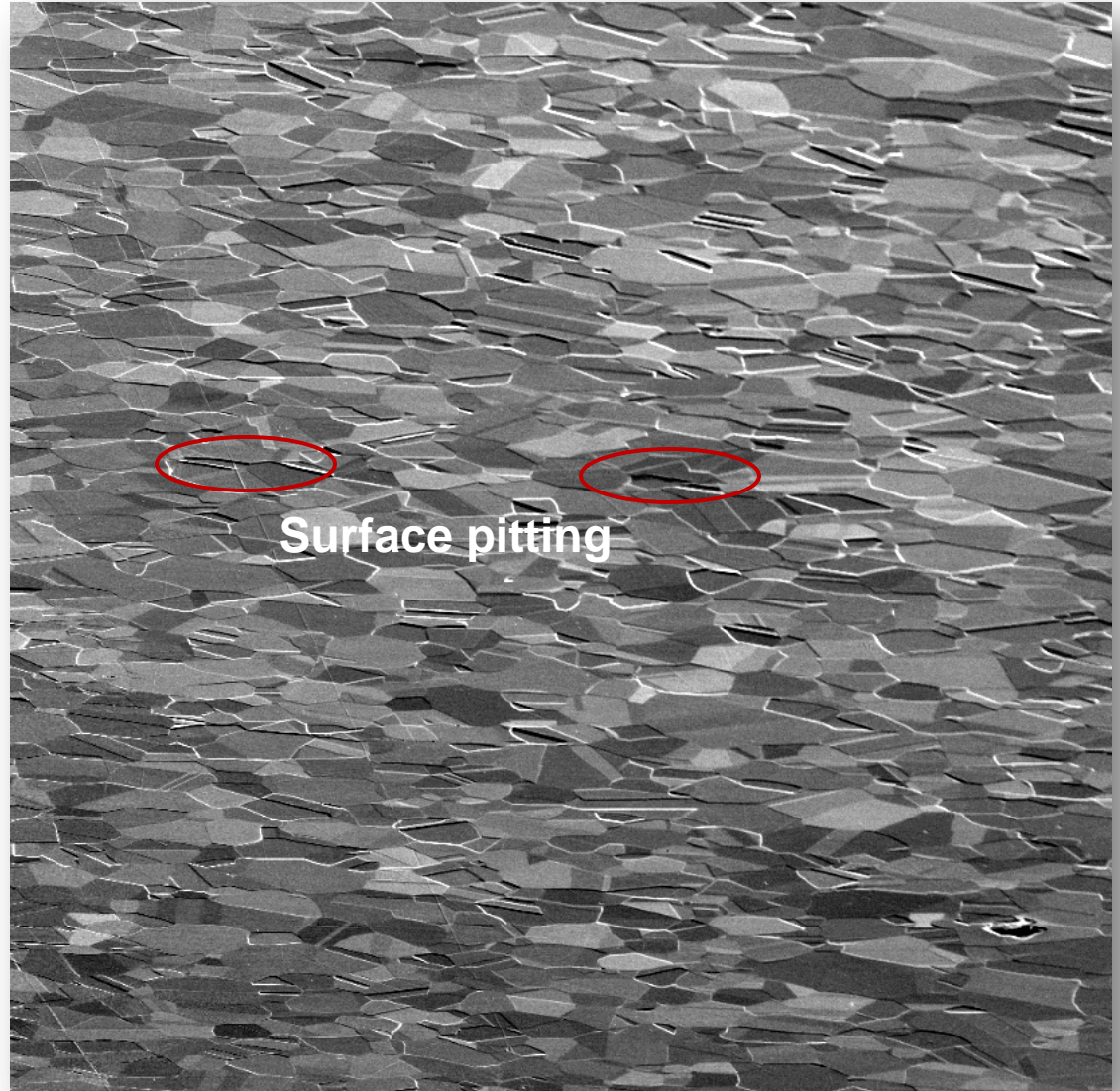
Image Resolution:	1024 by 768
Image Pixel Size:	0.33 μm
Acc. Voltage:	20.0 kV
Magnification:	405
Working Dist:	14.9 mm
Exposure Time:	9.0 ms
Indexing Success:	68.5 %



Left SEI image of transition region between MAGCIS and non-MAGCIS regions . **Centre** Orientation image map showing a low overall indexing success **Right** Grain boundary map, which does not return any meaningful information

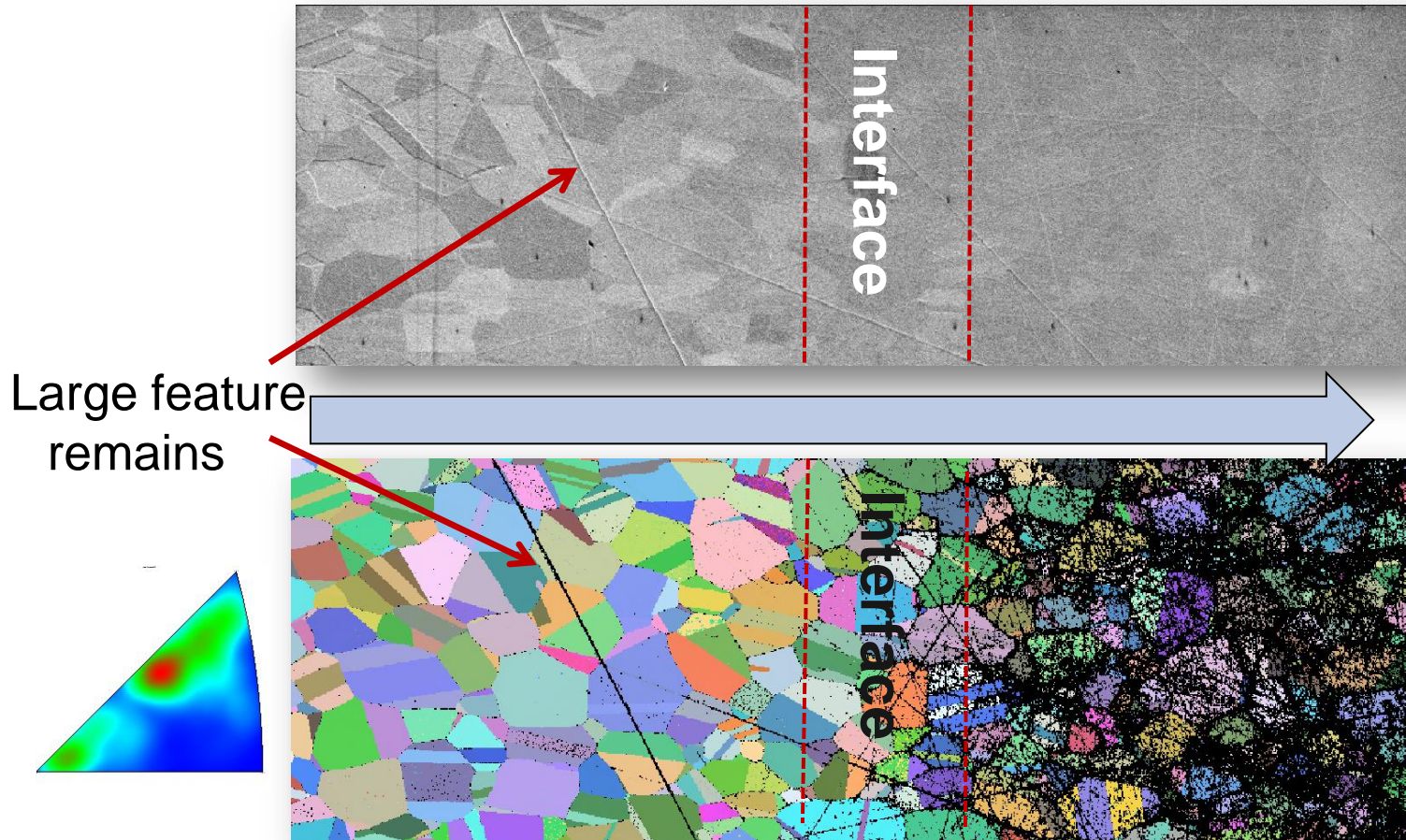
Application 1: Surface Topography

- Induced topography is related to beam energy
- 3 kV milling for 30 minutes results in some preferential etching of individual grains
- Less apparent at lower beam energy
- Results in shadowing and reduced EBSP quality



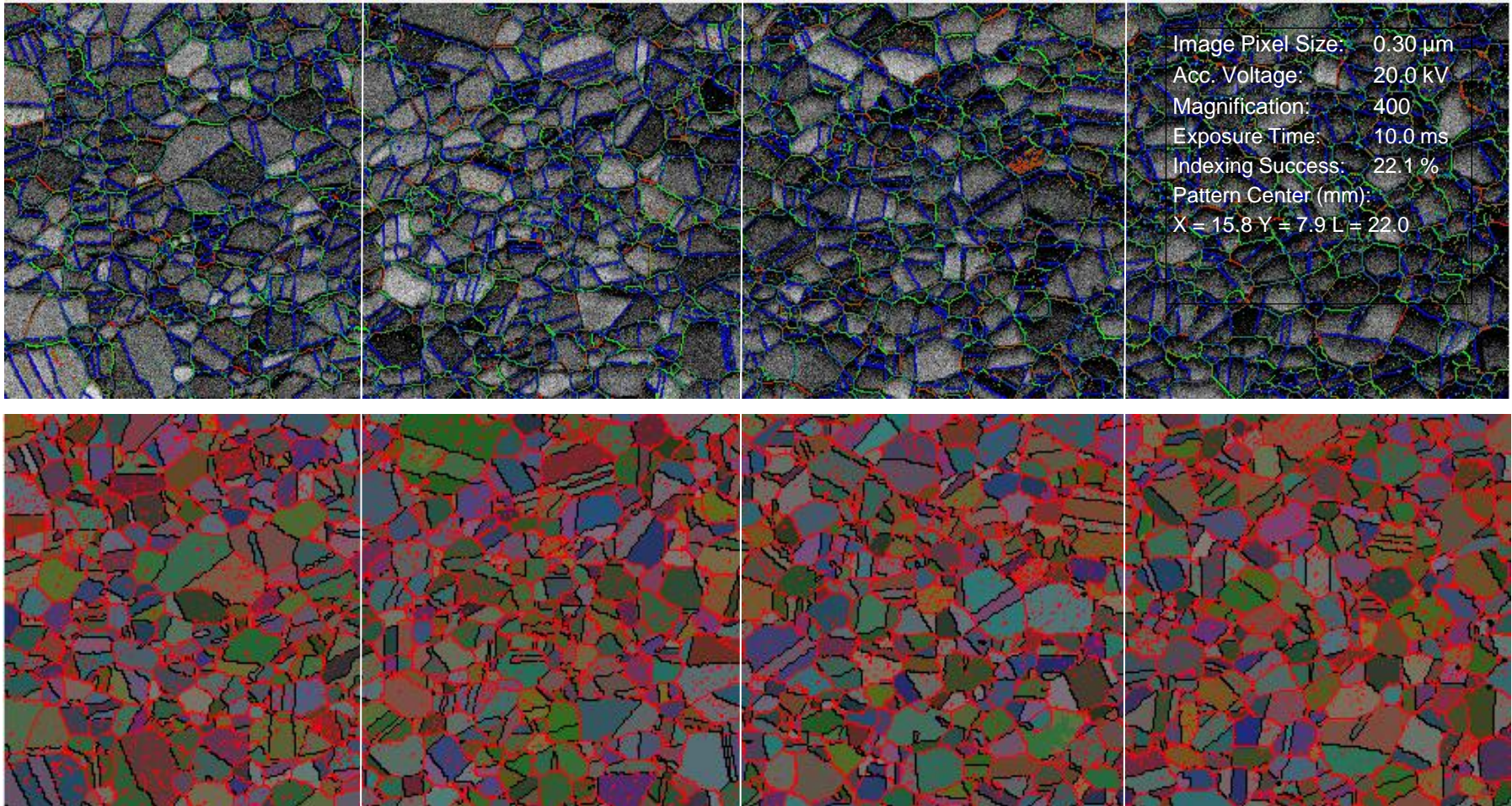
Application 1: Large Area Overview

- Lower kV (<2) MAGCIS induces smaller topographical effect
- Individual artefacts will remain
- Variable milling



Application 1: Large Area Mapping

- High resolution mapping shows twinning present within many grains
- No image enhancement required

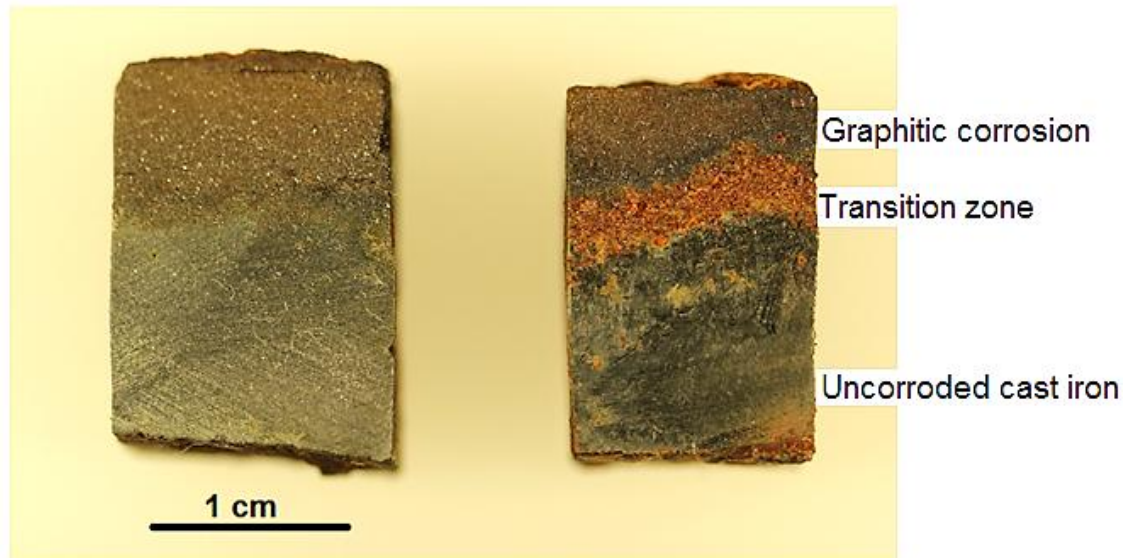


Application 1: Summary

- MAGCIS is an excellent tool for the preparation of soft materials such as gold alloys
- Large areas can be prepared for analysis very quickly, with little structural damage to the material
- Successfully indexed a fine small grain gold alloy

Application 2: Background

- Cast irons are ferrous irons consisting of 2-4% carbon, 1% Silicon and ~1% Phosphorous
- Distribution of regions can be seen using optical microscopy
- Multiple hard and soft phases, a challenge for traditional sample polishing

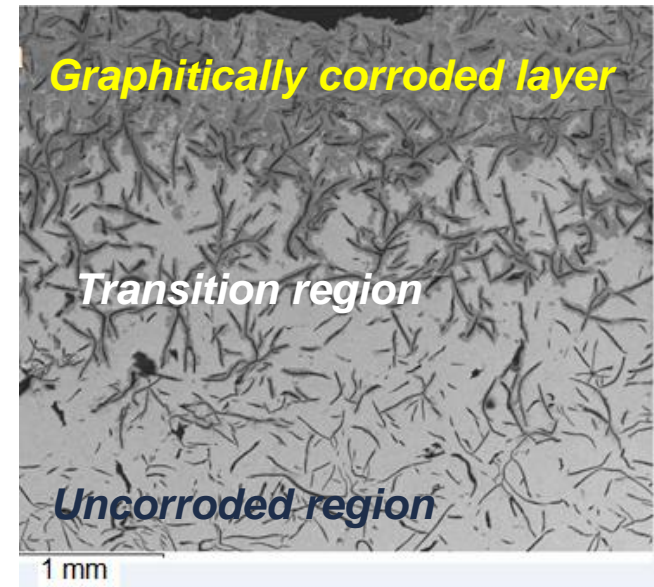
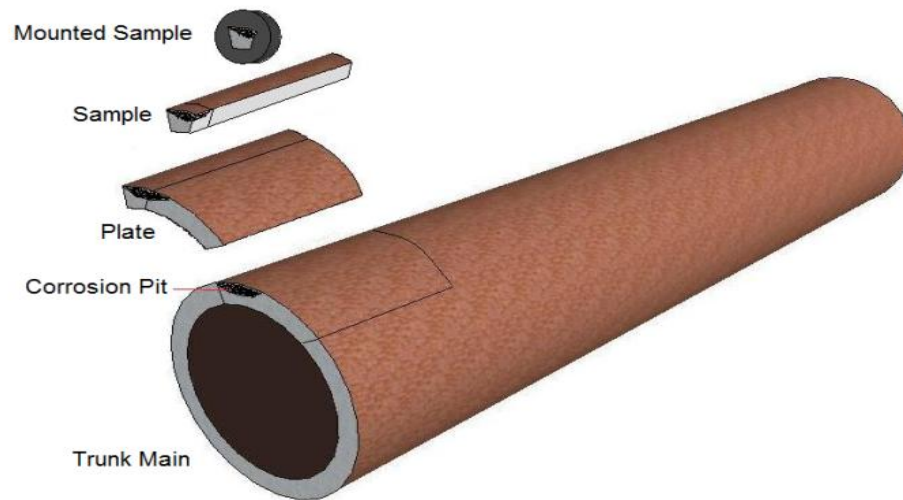


Optical microscopy image of corrosion regions.

R. Logan University of Surrey, UK

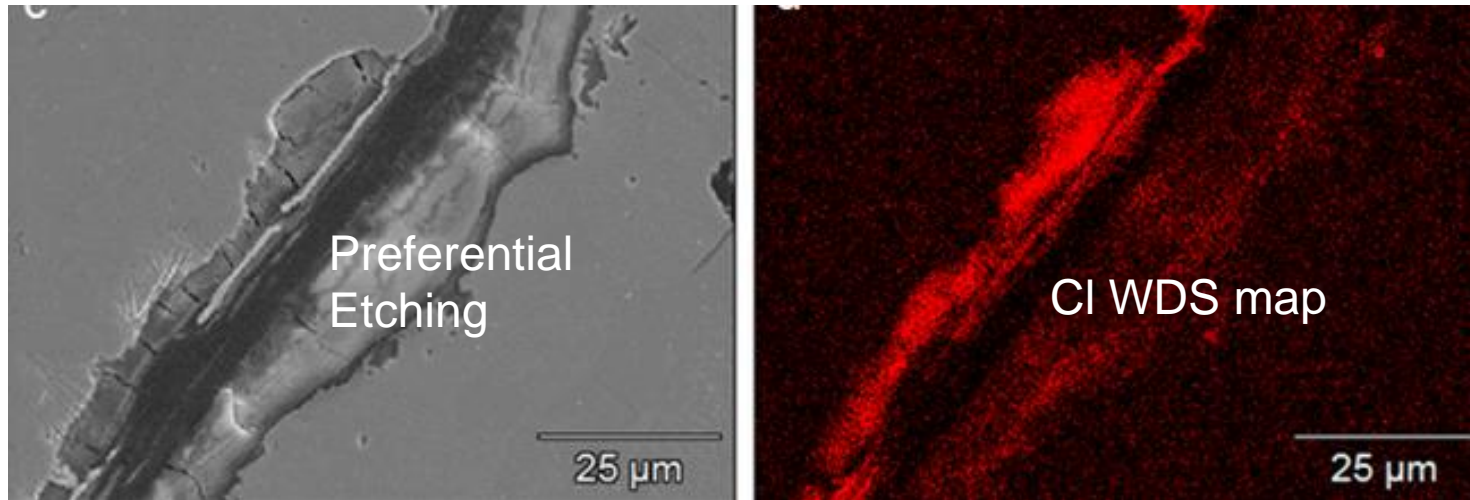
Application 2: Sample Preparation

- Sample mounted in Bakelite relative to the 'normal' axis
- Mechanical polish down to colloidal silica used for SEM, EDS and WDS analysis



WDS Characterisation

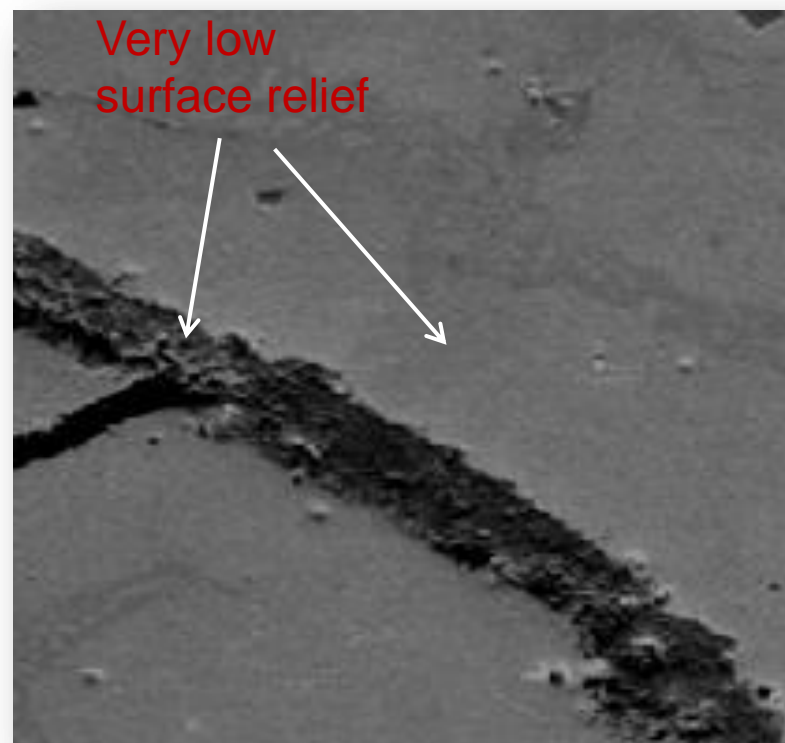
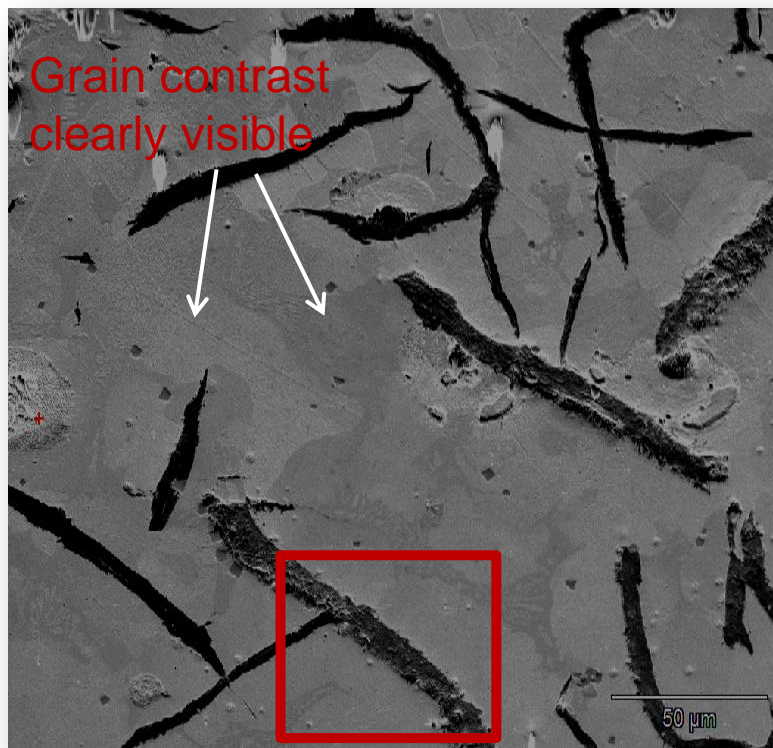
- WDS suggests trace Chlorine present in graphitic corrosion region
- No chloride detectable in uncorroded regions, therefore soil electrolyte concentration affects rate of corrosion
- Surfaces prepared in this way are too uneven to give complimentary EBSD structural information. No EBSPs observed



left SEM showing preferential etching, **right** WDS scan showing trace >1%

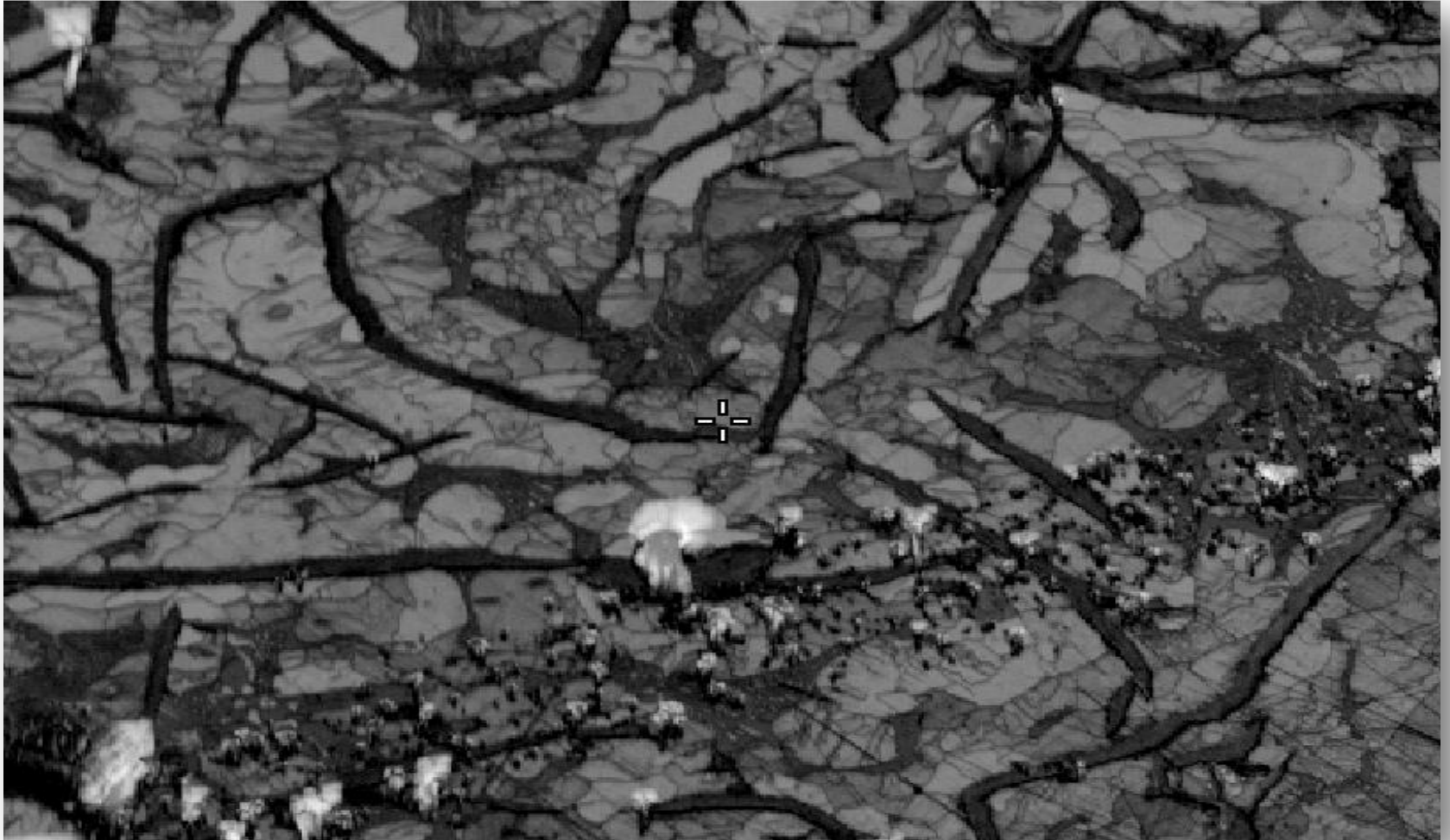
SEM Analysis of MAGCIS Sample Milling

- Samples etched using MAGCIS for 30 minutes at 3 kV monatomic, followed by 10 minutes at 1 kV cluster
- Low topographical differences between iron and carbon phases



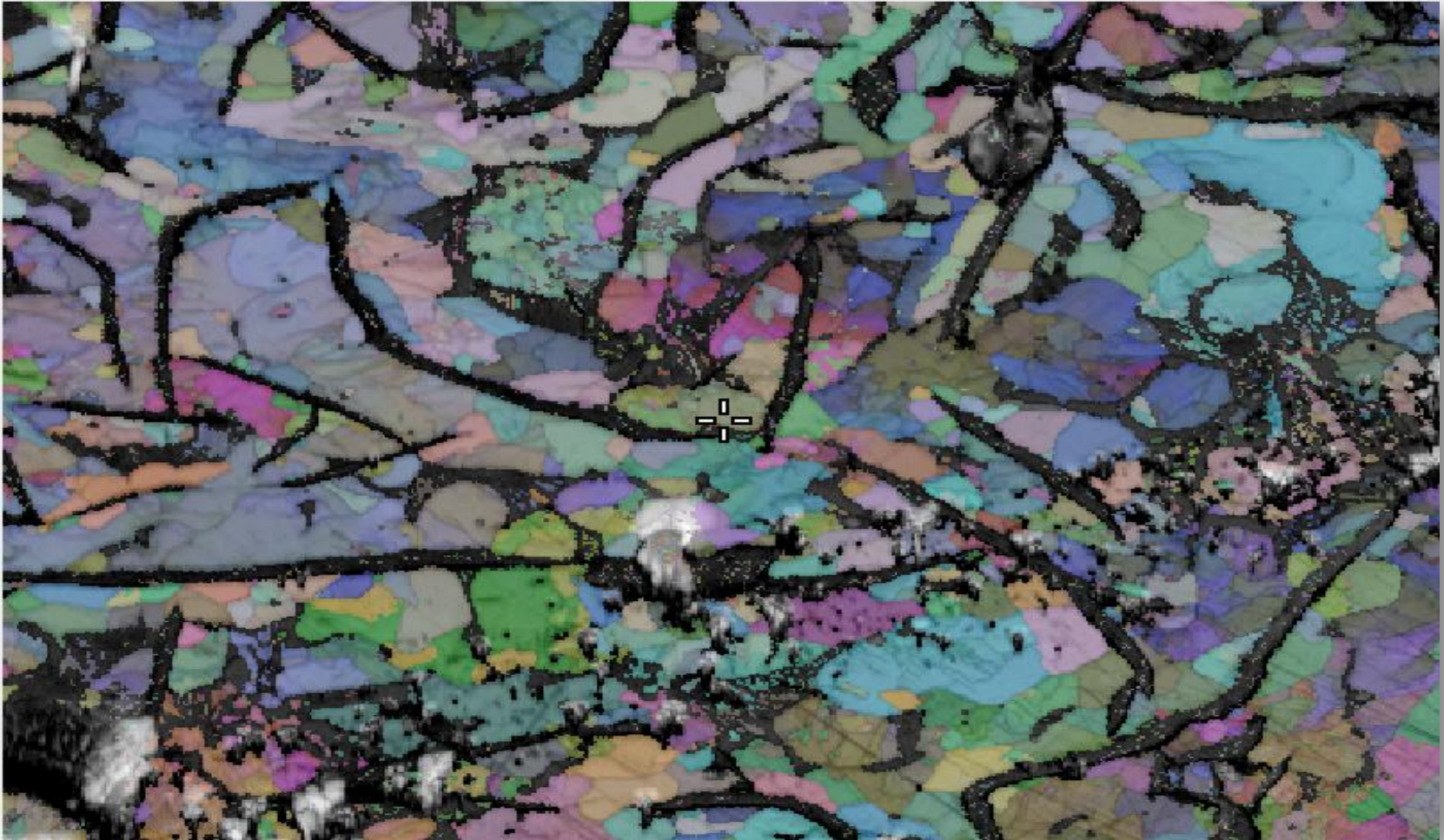
EBSD Pattern Quality Map

- Clearly shows grain boundaries and microstructure of ferrite phases



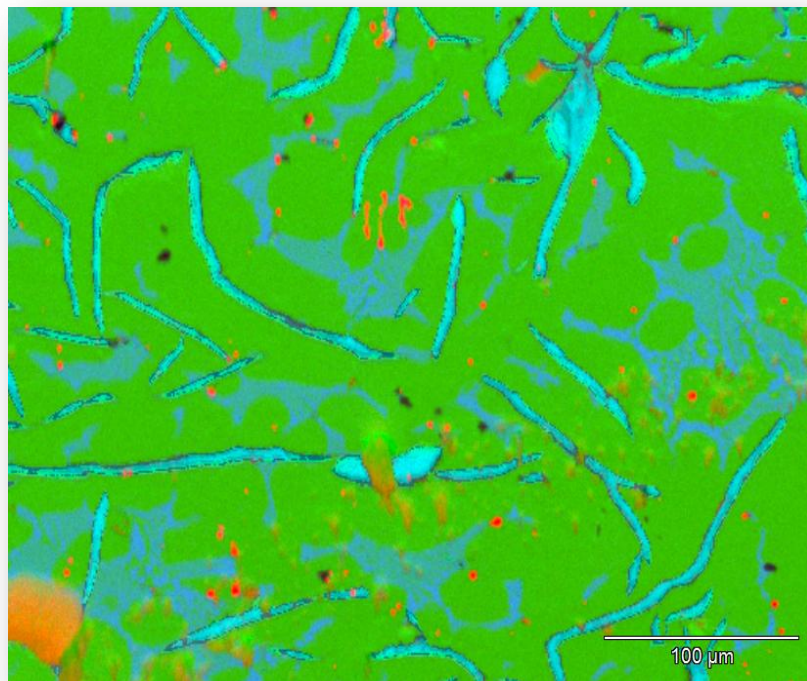
Euler Map

- Overlaid Euler map for texture classification of Ferrite phases

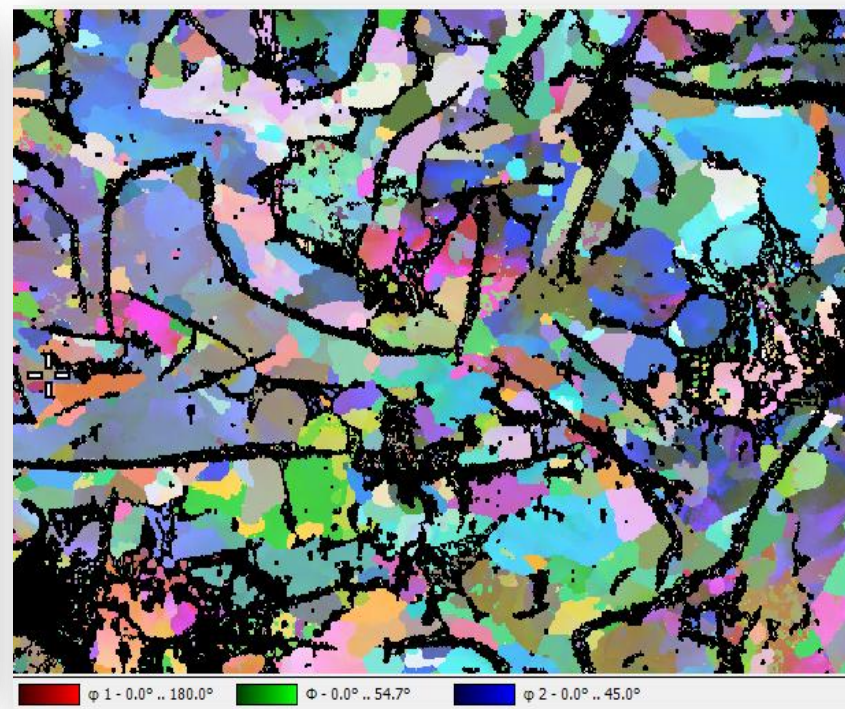


EDS/EBSD Comparisons

- Concurrent EDS analysis suggest that Ferrite phases and corrosion regions are currently indexed
- Carbon rich phases do not yield EBSPs



Fe C P O



Summary: MAGCIS in EBSD

- MAGCIS enables the characterisation of complex multiphase materials using EBSD
- Induces reduced mechanical damage when compared to conventional techniques
- An excellent *in-situ* preparation technique with further development opportunities